
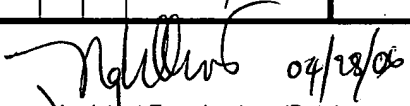
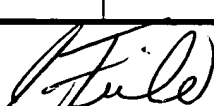
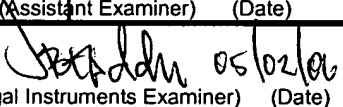


Issue Classification 	Application/Control No.		Applicant(s)/Patent under Reexamination	
	10/817,196		JAIN ET AL.	
	Examiner		Art Unit	
	David Q. Nguyen		2681	

ISSUE CLASSIFICATION											
ORIGINAL					CROSS REFERENCE(S)						
CLASS		SUBCLASS		CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)						
455		411		455	410	412.1	432.1	432.2	432.3	433	435.1
INTERNATIONAL CLASSIFICATION				455	436	439					
H	O	4	M	1/68	370	337					
				/	340	5.21	5.74				
				/	370	247	270				
				/							
				/							

 (Assistant Examiner) (Date)		 JOSEPH FEILD SUPERVISORY PATENT EXAMINER (Primary Examiner)		Total Claims Allowed: 17	
 (Legal Instruments Examiner) (Date)				O.G. Print Claim(s) 1	O.G. Print Fig. 1

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
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